

### SLOVENSKI STANDARD SIST EN 62271-101:2013/A1:2018

01-maj-2018

## Visokonapetostne stikalne in krmilne naprave - 101. del: Sintetično preskušanje - Dopolnilo A1 (IEC 62271-101:2012/A1:2017/COR1:2018)

High-voltage switchgear and controlgear - Part 101: Synthetic testing (IEC 62271-101:2012/A1:2017/COR1:2018)

Hochspannungs-Schaltgeräte und -Schaltanlagen - Teil 101: Synthetische Prüfung (IEC 62271-101:2012/A1:2017/COR1:2018) DARD PREVIEW

Appareillage à haute tension - Partie 101: Essais synthétiques (IEC 62271-101:2012/A1:2017/COR1:2018) <u>SIST EN 62271-101:2013/A1:2018</u> https://standards.iteh.ai/catalog/standards/sist/e8d86df4-a6c6-4a64-95d3-8ae225dafbc2/sist-en-62271-101-2013-a1-2018 Ta slovenski standard je istoveten z: EN 62271-101:2013/A1:2018

#### ICS:

29.130.10 Visokonapetostne stikalne in High voltage switchgear and krmilne naprave controlgear

SIST EN 62271-101:2013/A1:2018 en

### iTeh STANDARD PREVIEW (standards.iteh.ai)

<u>SIST EN 62271-101:2013/A1:2018</u> https://standards.iteh.ai/catalog/standards/sist/e8d86df4-a6c6-4a64-95d3-8ae225dafbc2/sist-en-62271-101-2013-a1-2018

### EUROPEAN STANDARD NORME EUROPÉENNE EUROPÄISCHE NORM

### EN 62271-101:2013/A1

March 2018

ICS 29.130.10

**English Version** 

# High-voltage switchgear and controlgear - Part 101: Synthetic testing (IEC 62271-101:2012/A1:2017 + COR1:2018)

Appareillage à haute tension - Partie 101: Essais synthétiques (IEC 62271-101:2012/A1:2017 + COR1:2018) Hochspannungs-Schaltgeräte und -Schaltanlagen - Teil 101: Synthetische Prüfung (IEC 62271-101:2012/A1:2017 + COR1:2018)

This amendment A1 modifies the European Standard EN 62271-101:2013; it was approved by CENELEC on 2018-01-04. CENELEC members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this amendment the status of a national standard without any alteration.

Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the CEN-CENELEC Management Centre or to any CENELEC member.

This amendment exists in three official versions (English, French, German). A version in any other language made by translation under the responsibility of a CENELEC member into its own language and notified to the CEN-CENELEC Management Centre has the same status as the official versions.

#### SIST EN 62271-101:2013/A1:2018

CENELEC members are the national electrotechnical committees of Austria, Belgium, Bulgaria, Croatia, Cyprus, the Czech Republic, Denmark, Estonia, Finland, Former Yugoslav, Republic of Macedonia, France, Germany, Greece, Hungary, Iceland, Ireland, Italy, Latvia, Lithuania, Luxembourg, Malta, the Netherlands, Norway, Poland, Portugal, Romania, Serbia, Slovakia, Slovenia, Spain, Sweden, Switzerland, Turkey and the United Kingdom.



European Committee for Electrotechnical Standardization Comité Européen de Normalisation Electrotechnique Europäisches Komitee für Elektrotechnische Normung

CEN-CENELEC Management Centre: Rue de la Science 23, B-1040 Brussels

#### EN 62271-101:2013/A1:2018 (E)

#### European foreword

The text of document 17A/1149/FDIS, future edition 1 of IEC 62271-101:2012/A1 prepared by IEC/SC 17A: "High-voltage switchgear and controlgear", of IEC/TC 17: "Switchgear and controlgear" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN 62271-101:2013/A1:2018.

The following dates are fixed:

•	latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement	(dop)	2018-10-04
•	latest date by which the national standards conflicting with the document have to be withdrawn	(dow)	2021-01-04

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. CENELEC shall not be held responsible for identifying any or all such patent rights.

#### **Endorsement notice**

The text of the International Standard IEC 62271-101:2012/A1:2017+ COR1:2018 was approved by CENELEC as a European Standard without any modification **REVIEW** 

### (standards.iteh.ai)

<u>SIST EN 62271-101:2013/A1:2018</u> https://standards.iteh.ai/catalog/standards/sist/e8d86df4-a6c6-4a64-95d3-8ae225dafbc2/sist-en-62271-101-2013-a1-2018

#### EN 62271-101:2013/A1:2018 (E)

Replace Annex ZA by the following:

#### Annex ZA

(normative)

### Normative references to international publications with their corresponding European publications

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 Where an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here: www.cenelec.eu.

Publication Year	<u>Title</u>	<u>EN/HD</u>	Year
IEC 62271-100 2008 + A1 2012 + A2 2017	High-voltage switchgear and controlgear - Part 100: Alternating current circuit-breakers	EN 62271-100 + A1 + A2	2009 2012 2017

### iTeh STANDARD PREVIEW (standards.iteh.ai)

SIST EN 62271-101:2013/A1:2018

https://standards.iteh.ai/catalog/standards/sist/e8d86df4-a6c6-4a64-95d3-8ae225dafbc2/sist-en-62271-101-2013-a1-2018

### iTeh STANDARD PREVIEW (standards.iteh.ai)

<u>SIST EN 62271-101:2013/A1:2018</u> https://standards.iteh.ai/catalog/standards/sist/e8d86df4-a6c6-4a64-95d3-8ae225dafbc2/sist-en-62271-101-2013-a1-2018





Edition 2.0 2017-11

## INTERNATIONAL STANDARD

## NORME INTERNATIONALE



AMENDMENT 1 AMENDEMENT 1

High-voltage switchgear and controlgear D PREVIEW Part 101: Synthetic testing (standards.iteh.ai)

Appareillage à haute tension<u>ST EN 62271-101:2013/A1:2018</u> Partie 101: Essaissynthétiques talog/standards/sist/e8d86df4-a6c6-4a64-95d3-8ae225dafbc2/sist-en-62271-101-2013-a1-2018

INTERNATIONAL ELECTROTECHNICAL COMMISSION

COMMISSION ELECTROTECHNIQUE INTERNATIONALE

ICS 29.130.10

ISBN 978-2-8322-4811-9

Warning! Make sure that you obtained this publication from an authorized distributor. Attention! Veuillez vous assurer que vous avez obtenu cette publication via un distributeur agréé.

 Registered trademark of the International Electrotechnical Commission Marque déposée de la Commission Electrotechnique Internationale

#### – 2 –

IEC 62271-101:2012/AMD1:2017 © IEC 2017

#### FOREWORD

This amendment has been prepared by subcommittee 17A: Switching devices, of IEC technical committee 17: High-voltage switchgear and controlgear.

The text of this amendment is based on the following documents:

FDIS	Report on voting
17A/1149/FDIS	17A/1154/RVD

Full information on the voting for the approval of this amendment can be found in the report on voting indicated in the above table.

The committee has decided that the contents of this amendment and the base publication will remain unchanged until the stability date indicated on the IEC website under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended. **iTeh STANDARD PREVIEW**

The contents of the corrigendum of January 2018 have been included in this copy.

IMPORTANT – The 'colour inside'llogo201 the <u>cover page</u> of this publication indicates that it contains <u>htcolours</u> dwhich at are staconsidered 86 to a be 4 useful3- for the correct understanding of its contents dusers should therefore print this document using a colour printer.

#### INTRODUCTION to the Amendment

This amendment includes the following significant technical changes:

- the test procedure for test-duty T100a has been aligned with IEC 62271-100;
- Annexes A through D have been transferred to IEC 62271-306;
- Annex I has been revised and now includes Annex P of IEC 62271-100;
- Annexes K, L and N have been revised.

#### 2 Normative references

Replace the existing reference to IEC 62271-100:2008 by the following new reference:

IEC 62271-100:2008, *High-voltage switchgear and controlgear – Part 100: Alternating current circuit-breakers* 

– 3 –

IEC 62271-100:2008/AMD 1:2012 IEC 62271-100:2008/AMD 2:2017

#### 3.17

#### minimum clearing time

Replace the entire term, definition, note and source as follows:

#### 3.17

(void)

Add, after the definition 3.18, a new term and definition as follows:

#### 3.19

#### intermediate asymmetry

level of asymmetry in the other two phases having a reduced (intermediate) level of asymmetry when in a three-phase system the short-circuit current is initiated simultaneously in all phases and maximum asymmetry is obtained in one of the phases

#### 4.1.2 High-current interval

Replace the entire subclause by the following:

The tolerance on the amplitude and the power frequency of the prospective breaking current is given in 6.103.2 and 6.104.3 of IEC 62271-100:2008. Therefore, the following conditions concerning the actual current through the test circuit-breaker shall be met:

- for symmetrical testing the current amplitude and final loop duration shall not be less than 90 % of the required values based on the current of the test-duty considered;
- for SLF test-duties and T100s and T100a when tested with ITRV, the product of the current amplitude and the duration of the final loop shall not be less than 95 % of the required values based on the current of the test-duty considered;
- for asymmetrical testing, both the current amplitude and final loop duration shall be between 90 % and 110 % of the required values, based on the current of the test-duty considered and time constant (see Tables L.12 to L.17).

In rare cases, where the applied voltage from the high current source is of the same magnitude as the required test voltage in a direct test circuit, a higher deviation of the last current loop is accepted provided that the prospective current loop with the auxiliary circuit-breaker arcing is within the specified tolerances.

#### 4.1.4 High-voltage interval

Replace the first sentence of the first hyphen by the following:

The initial value of the power-frequency recovery voltage, excluding the transient oscillations, shall not be less than the equivalent initial value of the power-frequency recovery voltage specified in 6.104.7 of IEC 62271-100:2008 which, for a test with symmetrical current, starts with a minimum peak value of  $0.95 \times k_{pp} \times U_r \sqrt{(2/3)}$ .

#### 4.2.1 Current injection methods

Replace, in the first sentence, "(see Annex B)" by "(see IEC 62271-306)".

Add, after the second indent, the following new sentences:

Current injection method is mandatory for:

short-line fault test duties;

– 4 –

IEC 62271-101:2012/AMD1:2017 © IEC 2017

T100s and T100a when tested with ITRV.

The time during which the arc is fed only by the injected current shall be treated as part of the length of the final current loop.

Replace the paragraph below the second hyphen by the following:

If any device with breaking capability interrupts the current through the test circuit-breaker at the same time as the test circuit-breaker, the method is not a valid current injection method.

Replace, in item c), "(see Annex B)" by "(see IEC 62271-306)".

#### 4.2.2 Voltage injection method

Replace, in the first sentence, "(see also Annex C)" by "(see IEC 62271-306)".

Delete the sentence below the third hyphen of the first list.

#### 4.2.3 Duplicate circuit method (transformer or Skeats circuit)

Replace, in the first sentence, "(see also Annex D)" by "(see IEC 62271-306)".

Delete the penultimate paragraph.

Replace, in the last paragraph, "See Annex D" by "See IEC 62271-306". (standards.iteh.ai)

#### 4.2.4 Other synthetic test methods

Remove the last two paragraphs. https://standards.tich.ai/catalog/standards/sist/e8d86df4-a6c6-4a64-95d3-8ae225dafbc2/sist-en-62271-101-2013-a1-2018

Table 3 – Test parameters during three-phase interruption for test-duties T10, T30, T60 and T100s,  $k_{pp} = 1.3$ 

Replace "98" by "97" (3 instances).

#### 5.2.2 Test circuit

Replace the second sentence of the first paragraph by the following:

Examples of circuits showing voltage and current wave shapes are given in Figures 5 and 6 for single-phase and Figure 7 for three-phase.

#### 6 Specific requirements for synthetic tests for making and breaking performance related to the requirements of 6.102 through 6.111 of IEC 62271-100:2008

Replace the existing title by the following new title:

#### 6 Type tests

Add, before the existing text of this clause, the following new title:

#### 6.1 General

Replace the second paragraph by the following new paragraphs and new table:

Requirements concerning testing of metal enclosed and dead tank circuit-breakers are given in Annex N.

General requirements for circuit-breakers with opening resistors are given in Annex R of IEC 62271-100:2008/AMD1:2012. A method available for testing circuit-breakers having opening resistors is reported in Annex F.

The abbreviations given in Table 6 are used to specify the operations to be performed.

Cd	Closing operation in a direct circuit at the voltage of the current source which can be less than the voltage specified in 6.104.1 of IEC 62271-100:2008				
(Cd)	Closing operation as Cd, which may be carried out under no-load conditions				
Cd <sub>asy</sub>	Closing operation against the rated short-circuit making current according to 6.104.2 of IEC 62271-100:2008/AMD2:2017 in a direct circuit at conditions described under Cd				
Cs <sub>sym</sub>	Closing operation against a symmetrical current equal to the rated short-circuit breaking current, carried out at the required applied voltage in a synthetic circuit				
Od	Breaking operation at the voltage of the current source only and with the specified breaking current				
Os	Breaking operation with specified parameters in a synthetic circuit				
t	Time interval between operations (0,3 s or 3 min depending on the rated operating sequence)				
t'	Time interval between operations (3 min)				
<i>t</i> "	Time interval between operations (15 s) DARD PREVIEW				
SP	Single-phase test as defined in 6,108 of IEC 62271-100:2008/AMD2:2017				
DEF	Double-earth fault test as defined in 6.108 of IEC 62271-100:2008/AMD2:2017				
NOTE Due to the characteristics of synthetic testing it may be difficult to comply with the specified time intervals of the rated operating sequence. See 6.1012 (attractive second seco					

#### Table 6 – Abbreviations used for operation during synthetic tests

8ae225dafbc2/sist-en-62271-101-2013-a1-2018

In order to comply with all test requirements, it may be necessary to make more operations than specified in the normal test-duty. In such cases the circuit-breaker may be reconditioned and the test duty repeated.

#### 6.102.10 Demonstration of arcing times

Replace the subclause by the following:

#### 6.102.10 Demonstration of arcing times

#### 6.102.10.1 General

The basic requirements to be met are given in 6.102.10 of IEC 62271-100:2008/AMD2:2017.

In order to be able to perform synthetic tests on the same basis as direct tests, normally it will be necessary to apply special re-ignition methods to prolong the arcing of the test circuitbreaker through the necessary number of zeros of the power-frequency current. See Annex H for re-ignition methods to prolong arcing.

The "step-by-step" method described in Annex H is the method used on most synthetic tests. The method is considered to be a sufficiently close approximation of the direct testing procedure.

The arcing is prolonged by means of thermal re-ignitions. As this method makes it possible to force the test circuit-breaker to re-ignite in all conditions, special care shall be taken not to re-ignite the circuit-breaker at the instant of a current zero when the circuit-breaker can clear. For this purpose it is necessary to determine, for each terminal fault, short-line fault and out-

of-phase test duty, the minimum arcing time of the circuit-breaker. At least two breaking tests, one clearance and one re-ignition, are necessary for this determination.

The clearance at the minimum arcing time is the first valid breaking operation. The other test is performed to demonstrate that a re-ignition at an early current zero would take place between the arcing contacts. This re-ignition test shall not be the last in a test duty.

For Od operations, a tolerance of  $\pm 2$  ms on the arcing time applies.

The extra tests necessary to demonstrate correct behaviour at early current zeros will usually contribute insignificantly to contact wear, etc., due to the short arcing times. Therefore, no reconditioning should be necessary because of these tests.

The re-ignition(s) obtained when determining the minimum arcing time do(es) not indicate a failure of the circuit-breaker. However, it is important to establish that this re-ignition has taken place between the arcing contacts only. When using a current injection method, the interruption of the injected current a few loops after the re-ignition is often a useful means for the judgement. Thorough inspection of screens, arcing and main contacts, etc., should also be made to verify correct behaviour.

NOTE When performing Od-COs, or COd-COs operations the first opening operation is performed in a direct test circuit. This first opening operation should represent the minimum arcing time found for single opening operations. In case the arcing time of this first opening operation is longer than required, the test is considered as more severe.

The minimum clearing time for test-duty T100a is validated by the minimum arcing time of an interruption after a major loop with intermediate asymmetry.

### (standards.iteh.ai)

#### 6.102.10.2 Three-phase tests

Depending on the test circuit used, the test procedures given here may not cover the conditions of the 3<sup>rd</sup> pole-to-clear for solidly earthed systems ( $k_{pp} = 1,3$ ). For this case the same procedures may be applied, with the manufacturer's consent, by combining the TRV and di/dt parameters for the 2<sup>nd</sup> pole-to-clear and the arcing time corresponding to the 3<sup>rd</sup> pole-to-clear. Alternatively, an additional test may be performed with the TRV, di/dt and the maximum arcing time corresponding to the 3<sup>rd</sup> pole-to-clear.

For alternative testing procedures of multi-enclosure type circuit-breakers with operating mechanism characteristics that require three-phase current, see Annex K.

#### 6.102.10.2.1 Test duties T10, T30, T60, T100s, T100s(b)

The test procedure is as follows:

For convenience of testing, the pole in phase A is kept as the first-pole-to-clear.

First the minimum arcing time and correct re-ignition behaviour are established. This is done by changing the setting of the tripping impulse in steps of 18° (possibly this has to be repeated several times). After having done so, the setting of the control of the tripping impulse has to be advanced by approximately 40°, starting from the shortest arcing time at which the circuit-breaker cleared. For the last test, the setting of the control of the tripping impulse has to be advanced by approximately 20°, starting from the shortest arcing time at which the circuit-breaker cleared:

- first valid breaking operation:  $t_{arc min}$ , minimum arcing time in phase A;
- re-ignition test:  $t_{\text{arc reig}} = t_{\text{arc min}} 18^\circ$ , re-ignition in phase A;
- second valid breaking operation:  $t_{arc max} = t_{arc min} + 40^\circ$ , longest arcing time in phase A;
- third valid breaking operation:  $t_{arc med} = t_{arc min} + 20^\circ$ , medium arcing time in phase A.

#### - 7 -

The first valid breaking operation and re-ignition test consist of single opening operations. The second and third valid breaking operations are carried out as part of the rated operating sequence. If the rated operating sequence is CO-15s-CO, the third valid breaking operation is not required (see 6.102.10 of IEC 62271-100:2008/AMD2:2017).

For comparison with the arcing time settings used in three-phase direct tests, see Figure 8.

#### 6.102.10.2.2 Test duty T100a

The intention is to demonstrate in a series of breaking tests the requirement a) and b) as defined in clause 6.102.10.2.2 of IEC 62271-100:2008/AMD2:2017:

- condition a) where arc extinction occurs in the first-pole-to-clear at the end of a major loop in the first phase with the required asymmetry criteria and with the longest possible arcing time  $t_{arc1}$ ;
- condition b) where arc extinction occurs at the end of an extended major loop in the lastpole-to-clear or in the second-pole-to-clear with the required asymmetry criteria and with the longest possible arcing time,  $t_{arc2}$  and  $t_{arc3}$  as follows:
  - the longest possible arcing time tarc2 applies for the last-pole-to-clear for circuitbreakers rated for  $k_{pp} = 1,5;$
  - the longest possible arcing time  $t_{arc3}$  applies for the second-pole-to-clear for circuitbreakers rated for  $k_{pp} = 1,3$  or 1,2.

### The test procedure, for three-phase testing is as follows: REVIEW

In order to simplify the test procedure, the pole in phase A is kept as the first-pole-to-clear. As a consequence the pole in phase C will be subjected to increased electrical wear. In order to obtain similar electrical wear on the poles of phase B and C, the test can be performed by exchanging the poles of phases B and C for the second breaking operation. https://standards.iteh.ai/catalog/standards

First the minimum arcing time  $t_{arc min}$  (Figures 9 and 10, first test) and re-ignition behaviour (Figures 9 and 10, second test) shall be demonstrated having intermediate asymmetry in phase A (Tables L.12 to L.17, columns 7, 8 and 9) and with the major extended loop occurring in phase C. This is done by changing the setting of the tripping impulse in steps of  $d\alpha = 18^{\circ}$ (possibly this has to be repeated several times).

Before the next operation, initiation of short-circuit current shall be advanced by 60° where the required asymmetry changes to phase A (Figures 9 and 10 third test). Arc extinction shall occur in phase A, the first-pole-to-clear at the end of a major loop with the required asymmetry criteria and with the maximum arcing time demonstrating condition a) mentioned above.

The maximum arcing time  $t_{arc1}$  for the first pole-to-clear is achieved when the following condition is met:

$$t_{arc1} = t_{arc min} + \Delta t_{a1} - T \times d\alpha/360^{\circ}$$

In the next operation, the initiation of short-circuit current shall be delayed by 60°. As a result the required asymmetry changes to phase C. Arc extinction shall occur in phase C at the end of a major extended loop with the required asymmetry criteria and with the maximum arcing time demonstrating condition b) mentioned above:

the maximum arcing time  $t_{arc2}$  for the last-pole-to-clear for circuit-breakers intended to be used in non-effectively earthed neutral systems (Figure 9 fourth test) is achieved when the following condition is met:

$$t_{arc2} = t_{arc min} + \Delta t_{a2} - T \times d\alpha/360^{\circ}$$

 the maximum arcing time t<sub>arc3</sub> for the second-pole-to-clear for circuit-breakers intended to be used in effectively earthed neutral systems (Figure 10 fourth test) is achieved when the following condition is met:

- 8 -

$$t_{arc3} = t_{arc min} + \Delta t_{a3} - T \times d\alpha/360^{\circ}$$

where  $\Delta t_{a1}$ ,  $\Delta t_{a2}$ ,  $\Delta t_{a3}$  are the relevant time parameters to be selected from Tables L.12 to L.17.

The order of the last two breaking operations can be interchanged.

Some circuit-breakers will not clear at the end of a major loop after the required arcing time. However, this test is valid if the circuit-breaker clears the subsequent minor loop, that becomes the last-pole-to-clear. The corresponding parameters for the last-pole-to-clear shall be applied.

For comparison with the arcing settings used in three-phase direct tests, see Figures 9 and 10.

### 6.102.10.3 Single-phase tests in substitution for three-phase conditions, out-of-phase and short-line fault tests

#### 6.102.10.3.1 General

The procedures as described in 6.102.10.3 of IEC 62271-100:2008/AMD2:2017 are applicable with the following changes. These procedures are meant to demonstrate the first-pole-to-clear, the second-pole-to-clear and the third-pole-to-clear conditions, with current and voltage parameters applicable for the first-pole-to-clear S.ICC.

#### 6.102.10.3.3 Test-duty T100a <u>SIST EN 62271-101:2013/A1:2018</u>

https://standards.iteh.ai/catalog/standards/sist/e8d86df4-a6c6-4a64-95d3-The test procedure is as follows225dafbc2/sist-en-62271-101-2013-a1-2018

The minimum arcing time  $t_{arc\ min}$  and re-ignition behaviour shall be demonstrated with the major loop at intermediate asymmetry (Tables L.12 to L.17, columns 8 and 9). This is done by changing the setting of the tripping impulse in steps of 18° (possibly this has to be repeated several times).

After that, two breaking operations at required asymmetry shall be performed as described below. Tables L.12 to L.17, columns 3 and 4, give the required values of the peak short-circuit current and loop duration that shall be attained in the last loop prior to the interruption.

One breaking operation, corresponding to condition a) of 6.102.10.2.2 of IEC 62271-100:2008/AMD2:2017, shall demonstrate interruption at the end of the major loop with an arcing time equivalent to the maximum arcing time under three-phase conditions  $t_{arc1}$  of the first-pole-to-clear.

The maximum arcing time  $t_{arc1}$  for the first pole-to-clear is achieved when the following condition is met:

$$t_{arc1} = t_{arc min} + \Delta t_{a1} - T \times d\alpha/360^{\circ}$$

Another breaking operation, corresponding to condition b) of 6.102.10.2.2 of IEC 62271-100:2008/AMD2:2017, shall demonstrate interruption at the end of the major loop with an arcing time equivalent to the maximum arcing time under three-phase conditions:

- the maximum arcing time  $t_{arc2}$  for the last-pole-to-clear for circuit-breakers intended to be used in non-effectively earthed neutral systems ( $k_{pp} = 1,5$ ) is achieved when the following condition is met:

 $t_{arc2} = t_{arc min} + \Delta t_{a2} - T \times d\alpha/360^{\circ}$ 

- the maximum arcing time  $t_{arc3}$  for the second-pole-to-clear for circuit-breakers intended to be used in effectively earthed neutral systems ( $k_{pp} = 1,3$  or  $k_{pp} = 1,2$ ) is achieved when the following condition is met:

$$t_{arc3} = t_{arc min} + \Delta t_{a3} - T \times d\alpha/360^{\circ}$$

where  $\Delta t_{a1}$ ,  $\Delta t_{a2}$ ,  $\Delta t_{a3}$  are the relevant time parameters to be selected from Tables L.12 to L.17.

The order of the last two breaking operations may be interchanged.

Since some circuit-breakers will not clear after a major loop, a test is still valid if the circuitbreaker interrupts at the subsequent minor loop.

### 6.102.10.3.5 Splitting of test-duties in test series, taking into account the associated TRV for each pole-to-clear

The procedures as described in 6.102.10.3.5 of IEC 62271-100:2008/AMD2:2017 are applicable and the test procedure for synthetic testing is given in Annex L.

## 6.102.10.3.101 Modified procedure in cases where the circuit-breaker did not interrupt during a test with a medium arcing time, during breaking tests with symmetrical current DARD PREVIEW

If the circuit-breaker did not interrupt at the expected current zero during a breaking operation with symmetrical current with a medium arcing time then it is necessary to perform an additional breaking operation. <u>SIST EN 62271-101:2013/A1:2018</u>

https://standards.iteh.ai/catalog/standards/sist/e8d86df4-a6c6-4a64-95d3-

The breaking operation shall demonstrate interruption with the "ultimate maximum arcing time" tarc ult max which is:

 $t_{\rm arc \ ult \ max} = t_{\rm arc \ med} + T \times (150 \ / \ 360), \text{ if } k_{\rm pp} = 1,5$ 

 $t_{\rm arc \ ult \ max} = t_{\rm arc \ med} + T \times$  (180 / 360), if  $k_{\rm pp} =$  1,3, 1,2 or 1,0

where

*t*<sub>arc med</sub> is the medium arcing time at which the circuit-breaker did not interrupt;

*t*<sub>arc ult max</sub> is the ultimate maximum arcing time.

If the circuit-breaker does not interrupt during this additional breaking operation, it is permissible to carry out maintenance work on the circuit-breaker according to 6.102.9.5 of IEC 62271-100:2008/AMD2:2017 and repeat the test-duty where the breaking operation with the medium arcing time is replaced by the breaking operation with the ultimate maximum arcing time.

For test duties T10, T30, T60,  $L_{90}$ ,  $L_{75}$  and  $L_{60}$ , the  $t_{arc ult max}$  is demonstrated with (Cd)Os.

For test duty T100s, the  $t_{arc ult max}$  is demonstrated with CdOs.

For OP1 and OP2 test duties, the  $t_{arc ult max}$  is demonstrated with Os.

#### 6.106 Basic short-circuit test-duties

Delete the second paragraph and the list of abbreviations.